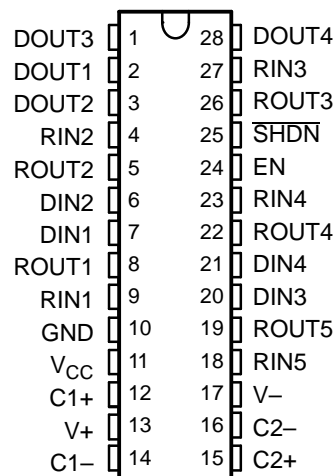


## FEATURES

- ESD Protection for RS-232 Bus Pins  
–  $\pm 15$ -kV Human-Body Model (HBM)
- Meets or Exceeds the Requirements of  
TIA/EIA-232-F and ITU v.28 Standards
- Operates at 5-V  $V_{CC}$  Supply
- Four Drivers and Five Receivers
- Operates up to 120 kbit/s
- Low Supply Current in Shutdown  
Mode . . . 15  $\mu$ A Typ
- External Capacitors . . .  $4 \times 0.1$  F
- Designed to Be Interchangeable With Maxim  
MAX213
- Latch-Up Performance Exceeds 100 mA Per  
JESD 78, Class II

DB, DW, OR PW PACKAGE  
(TOP VIEW)



## APPLICATIONS

- Battery-Powered Systems
- PDAs
- Notebooks
- Laptops
- Palmtop PCs
- Hand-Held Equipment

## DESCRIPTION/ ORDER INFORMATION

The MAX213 device consists of four line drivers, five line receivers, and a dual charge-pump circuit with  $\pm 15$ -kV ESD protection pin to pin (serial-port connection pins, including GND). The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 5-V supply. The devices operate at data signaling rates up to 120 kbit/s and a maximum of 30-V/ $\mu$ s driver output slew rate.

The MAX213 has an active-low shutdown ( $\overline{\text{SHDN}}$ ) and an active-high enable control (EN). In shutdown mode, the charge pumps are turned off, V+ is pulled down to V<sub>CC</sub>, V- is pulled to GND, and the transmitter outputs are disabled. This reduces supply current typically to 1  $\mu$ A. Two receivers of the MAX213 are active during shutdown.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

**MAX213**  
**5-V MULTICHANNEL RS-232 LINE DRIVER/RECEIVER**  
**WITH  $\pm 15$ -kV ESD PROTECTION**

SLLS680–DECEMBER 2005

**ORDERING INFORMATION**

$T_A$	PACKAGE <sup>(1)</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING
0°C to 70°C	SOIC – DW	Tube of 20	MAX213CDW	
		Reel of 1000	MAX213CDWR	
	SSOP – DB	Tube of 50	MAX213CDB	
		Reel of 2000	MAX213CDBR	
	TSSOP – PW	Tape and reel	MAX213CPWR	
–40°C to 85°C	SOIC – DW	Tube of 20	MAX213IDW	
		Reel of 1000	MAX213IDWR	
	SSOP – DB	Tube of 50	MAX213IDB	
		Reel of 2000	MAX213IDBR	
	TSSOP – PW	Tape and reel	MAX213IPWR	

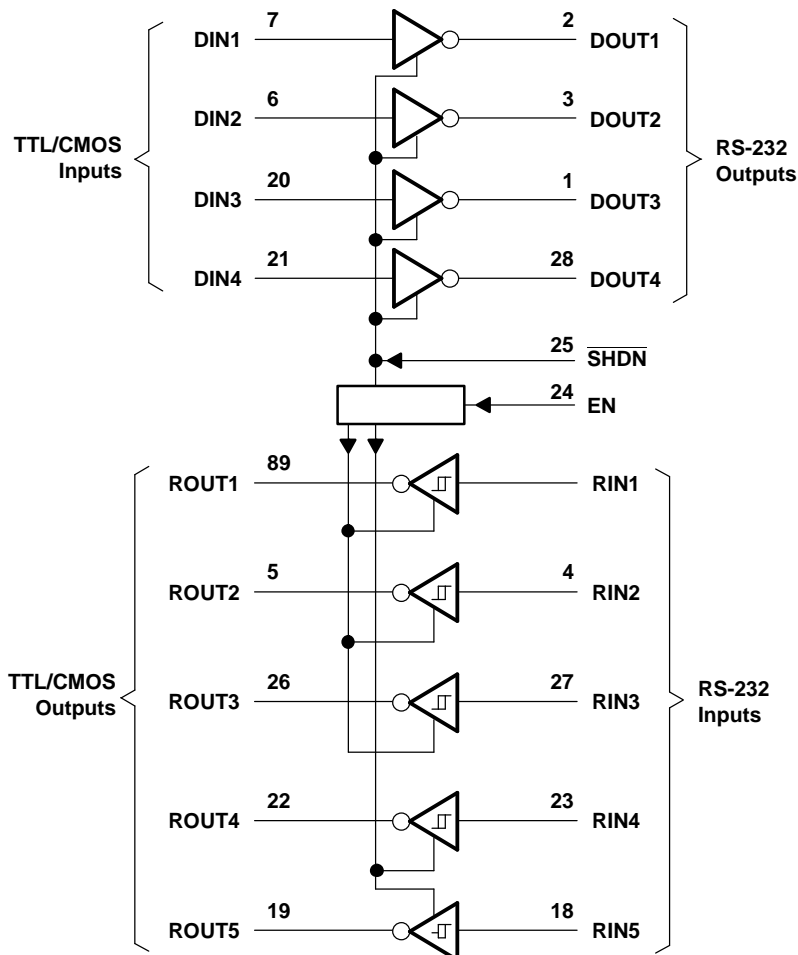
(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at [www.ti.com/sc/package](http://www.ti.com/sc/package).

**FUNCTION TABLE**

INPUTS		DRIVER D1–D4	RECEIVER		DEVICE STATUS
$\overline{\text{SHDN}}$	EN		R1–R3	R4–R5	
L	L	Z	Z	Z	Shutdown
L	H	Z	Z	Active <sup>(1)</sup>	Shutdown
H	L	All active	Z	Z	Normal operation
H	H	All active	Active	Active	Normal operation

(1) See the  $V_{IT+}$  and  $V_{IT-}$  change in the *Electrical Characteristics* table.

LOGIC DIAGRAM (POSITIVE LOGIC)



# MAX213

## 5-V MULTICHANNEL RS-232 LINE DRIVER/RECEIVER

### WITH $\pm 15$ -kV ESD PROTECTION

SLLS680–DECEMBER 2005



#### Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		−0.3	6	V
V+	Positive charge-pump voltage range <sup>(2)</sup>		V <sub>CC</sub> − 0.3	14	V
V−	Negative charge-pump voltage range <sup>(2)</sup>		0.3	−14	V
V <sub>I</sub>	Input voltage range	Drivers	−0.3	V+ + 0.3	V
		Receivers		±30	
V <sub>O</sub>	Output voltage range	Drivers	V− − 0.3	V+ + 0.3	V
		Receivers	−0.3	V <sub>CC</sub> + 0.3	
DOUT	Short-circuit duration		Continuous		
θ <sub>JA</sub>	Package thermal impedance <sup>(3)(4)</sup>	DB package		62	C°/W
		DW package		46	
		PW package			
T <sub>J</sub>	Operating virtual junction temperature			150	C°
T <sub>sta</sub>	Storage temperature range		−65	150	C°

- (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages are with respect to network GND.
- (3) Maximum power dissipation is a function of  $T_J(\text{max})$ ,  $\theta_{JA}$ , and  $T_A$ . The maximum allowable power dissipation at any allowable ambient temperature is  $P_D = (T_J(\text{max}) - T_A)/\theta_{JA}$ . Operating at the absolute maximum  $T_J$  of 150°C can affect reliability.
- (4) The package thermal impedance is calculated in accordance with JESD 51-7.

#### Recommended Operating Conditions<sup>(1)</sup>

See [Figure 4](#)

			MIN	NOM	MAX	UNIT
	Supply voltage		4.5	5	5.5	V
$V_{IH}$	Driver high-level input voltage	DIN	2			V
	Control high-level input voltage	EN, $\overline{\text{SHDN}}$	2.4			
$V_{IL}$	Driver and control low-level input voltage	DIN, EN, $\overline{\text{SHDN}}$			0.8	V
$V_I$	Driver and control input voltage	DIN, EN, $\overline{\text{SHDN}}$	0		5.5	V
	Receiver input voltage	RIN	–30		30	
$T_A$	Operating free-air temperature	MAX213C	0		70	°C
		MAX213I	–40		85	

- (1) Test conditions are C1–C4 = 0.1  $\mu\text{F}$  at  $V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$ .

#### Electrical Characteristics<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
$I_{CC}$	Supply current	No load, See <a href="#">Figure 6</a>	14	20	mA
$I_{SHDN}$	Shutdown supply current	$T_A = 25^\circ\text{C}$ , See <a href="#">Figure 1</a>	15	50	$\mu\text{A}$

- (1) Test conditions are C1–C4 = 0.1  $\mu\text{F}$  at  $V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$ .
- (2) All typical values are at  $V_{CC} = 5 \text{ V}$ , and  $T_A = 25^\circ\text{C}$ .

## DRIVER SECTION

### Electrical Characteristics<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted) (see [Figure 4](#))

PARAMETER		TEST CONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
V <sub>OH</sub>	High-level output voltage	DOUT at R <sub>L</sub> = 3 k $\Omega$ to GND	5	9		V
V <sub>OL</sub>	Low-level output voltage	DOUT at R <sub>L</sub> = 3 k $\Omega$ to GND	–5	–9		V
I <sub>IH</sub>	Control high-level input current	EN, $\overline{\text{SHDN}}$ = 5 V		3	10	$\mu$ A
I <sub>IL</sub>	Driver low-level input current	DIN = 0 V		–15	–200	$\mu$ A
	Control low-level input current	EN, $\overline{\text{SHDN}}$ = 0 V		–3	–10	
I <sub>OS</sub> <sup>(3)</sup>	Short-circuit output current	V <sub>CC</sub> = 5.5 V, V <sub>O</sub> = 0 V		$\pm 10$	$\pm 60$	mA
r <sub>o</sub>	Output resistance	V <sub>CC</sub> , V <sub>+</sub> , and V <sub>–</sub> = 0 V, V <sub>O</sub> = $\pm 2$ V	300			$\Omega$

(1) Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 5 V  $\pm$  0.5 V

(2) All typical values are at V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C.

(3) Short-circuit durations should be controlled to prevent exceeding the device absolute power dissipation ratings, and not more than one output should be shorted at a time.

### Switching Characteristics<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
Maximum data rate		C <sub>L</sub> = 50 pF to 1000 pF, One DOUT switching, R <sub>L</sub> = 3 k $\Omega$ to 7 k $\Omega$ , See <a href="#">Figure 3</a>	120			kbit/s
t <sub>PLH(D)</sub>	Propagation delay time, low- to high-level output	C <sub>L</sub> = 2500 pF, All drivers loaded, R <sub>L</sub> = 3 k $\Omega$ , See <a href="#">Figure 3</a>		2		$\mu$ s
t <sub>PHL(D)</sub>	Propagation delay time, high- to low-level output	C <sub>L</sub> = 2500 pF, All drivers loaded, R <sub>L</sub> = 3 k $\Omega$ , See <a href="#">Figure 3</a>		2		$\mu$ s
t <sub>sk(p)</sub>	Pulse skew <sup>(3)</sup>	C <sub>L</sub> = 150 pF to 2500 pF, See <a href="#">Figure 3</a> R <sub>L</sub> = 3 k $\Omega$ to 7 k $\Omega$ ,		300		ns
SR(tr)	Slew rate, transition region (see <a href="#">Figure 2</a> )	C <sub>L</sub> = 50 pF to 1000 pF, V <sub>CC</sub> = 5 V R <sub>L</sub> = 3 k $\Omega$ to 7 k $\Omega$ ,	3	6	30	V/ $\mu$ s

(1) Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 5 V  $\pm$  0.5 V.

(2) All typical values are at V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C.

(3) Pulse skew is defined as (t<sub>PLH</sub> – t<sub>PHL</sub>) of each channel of the same device.

## ESD Protection

over operating free-air temperature range (unless otherwise noted)

PIN	TEST CONDITIONS	TYP	UNIT
DOUT	Human-Body Model	$\pm 15$	kV

# MAX213

## 5-V MULTICHANNEL RS-232 LINE DRIVER/RECEIVER

### WITH $\pm 15$ -kV ESD PROTECTION

SLLS680–DECEMBER 2005



## RECEIVER SECTION

### Electrical Characteristics<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted) (see [Figure 6](#))

PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
V <sub>OH</sub> High-level output voltage	I <sub>OH</sub> = –1 mA	V <sub>CC</sub> – 0.4			V
V <sub>OL</sub> Low-level output voltage	I <sub>OH</sub> = 1.6 mA	0.4			V
V <sub>IT+</sub> Positive-going input threshold voltage	V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C	Active mode		1.7	2.4
		Shutdown mode (R4–R5)		1.5	2.4
V <sub>IT–</sub> Negative-going input threshold voltage	V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C	Active mode		0.8	1.2
		Shutdown mode (R4–R5)		0.6	1.5
V <sub>hys</sub> <sup>(3)</sup> Input hysteresis (V <sub>IT+</sub> , V <sub>IT–</sub> )	V <sub>CC</sub> = 5 V	0.5			1
r <sub>i</sub> Input resistance	V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C	3	5	7	kΩ
Output leakage current	EN = 0 V, 0 ≤ ROUT ≤ V <sub>CC</sub> , R1–R3	±0.05			±10

(1) Test conditions are C1–C4 = 0.1 μF at V<sub>CC</sub> = 5 V ± 0.5 V.

(2) All typical values are at V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C.

(3) No hysteresis in shutdown mode

### Switching Characteristics<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(2)</sup>	MAX	UNIT
t <sub>PLH(R)</sub> Propagation delay time, low- to high-level output	C <sub>L</sub> = 150 pF, See <a href="#">Figure 4</a>	SHDN = V <sub>CC</sub>		0.5	10
		SHDN = 0 V, R4–R5		4	40
t <sub>PHL(R)</sub> Propagation delay time, high- to low-level output	C <sub>L</sub> = 150 pF, See <a href="#">Figure 4</a>	0.5			10
t <sub>en</sub> Output enable time	C <sub>L</sub> = 150 pF, See <a href="#">Figure 5</a>	600			ns
t <sub>dis</sub> Output disable time	C <sub>L</sub> = 150 pF, See <a href="#">Figure 5</a>	200			ns

(1) Test conditions are C1–C4 = 0.1 μF at V<sub>CC</sub> = 5 V ± 0.5 V.

(2) All typical values are at V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C.

## ESD Protection

over operating free-air temperature range (unless otherwise noted)

PIN	TEST CONDITIONS	TYP	UNIT
RIN	Human-Body Model	±15	kV

# PARAMETER MEASUREMENT INFORMATION

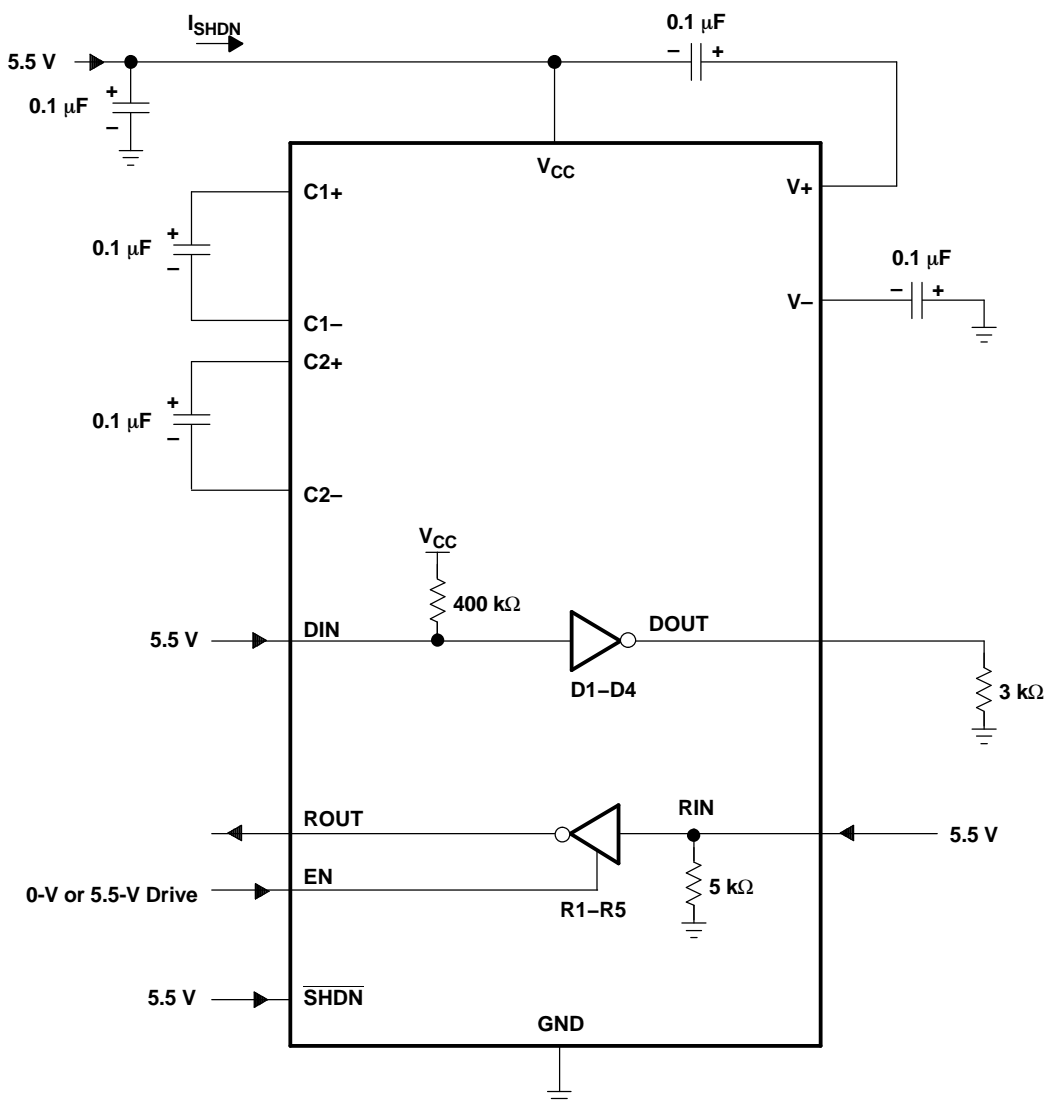
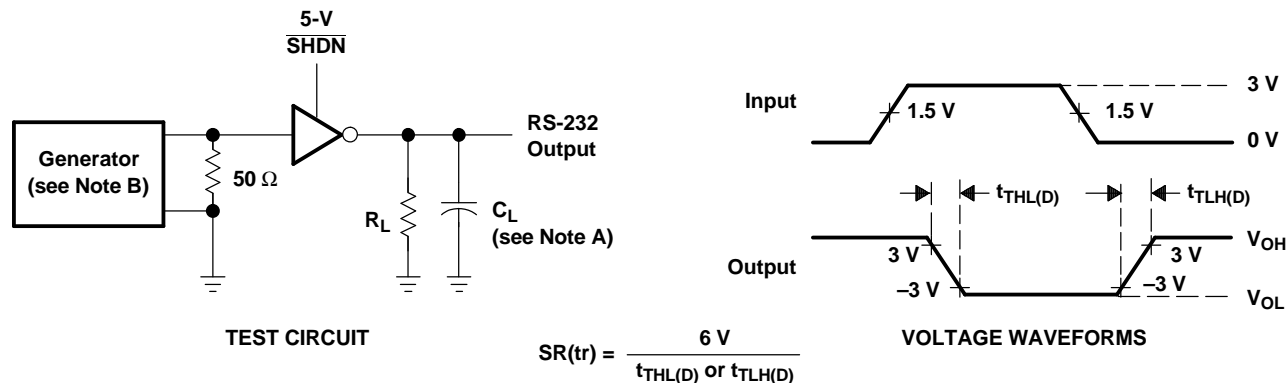
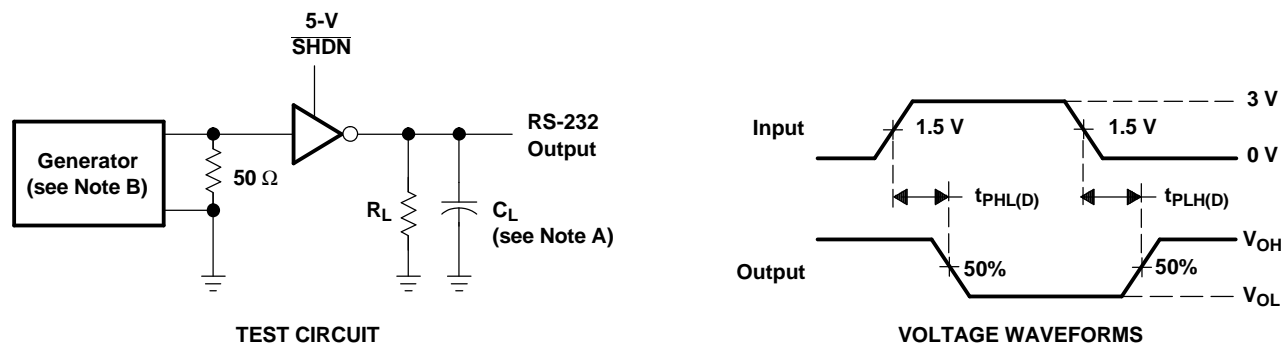


Figure 1. Shutdown Current Test Circuit

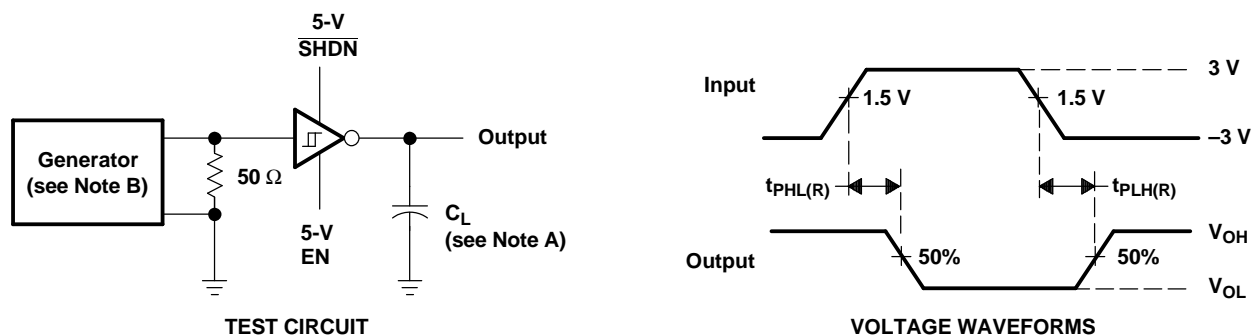
## PARAMETER MEASUREMENT INFORMATION (continued)



**Figure 2. Driver Slew Rate**



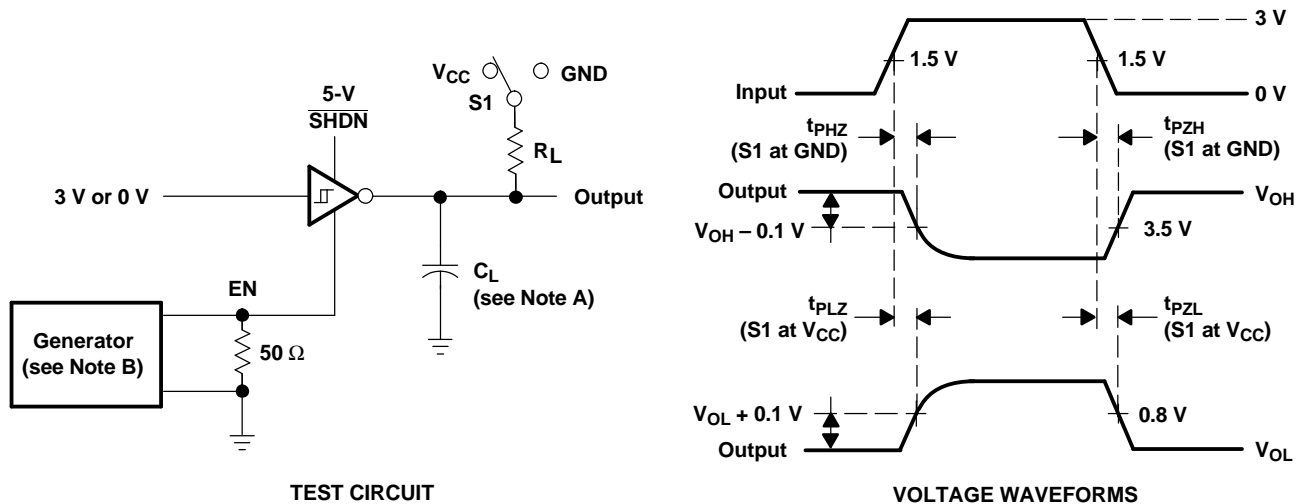
**Figure 3. Driver Pulse Skew and Propagation Delay Times**



**Figure 4. Receiver Propagation Delay Times**



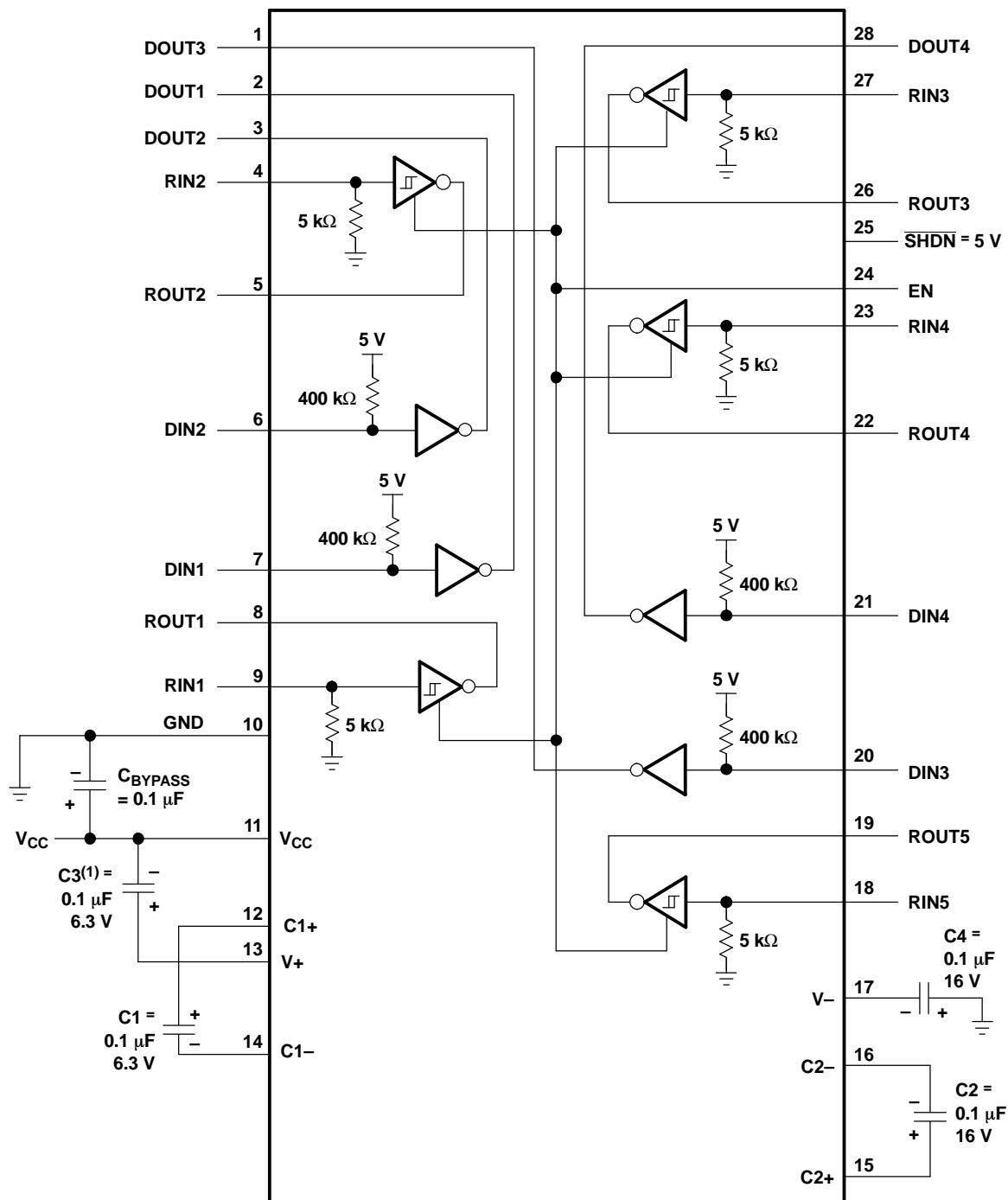
PARAMETER MEASUREMENT INFORMATION (continued)



- NOTES:
- A.  $C_L$  includes probe and jig capacitance.
  - B. The pulse generator has the following characteristics:  $Z_O = 50\ \Omega$ , 50% duty cycle,  $t_r \leq 10\text{ ns}$ ,  $t_f \leq 10\text{ ns}$ .
  - C.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
  - D.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .

Figure 5. Receiver Enable and Disable Times

## APPLICATION INFORMATION



(1) C3 can be connected to  $V_{CC}$  or GND.

NOTES: A. Resistor values shown are nominal.

B. Nonpolarized ceramic capacitors are acceptable. If polarized tantalum or electrolytic capacitors are used, they should be connected as shown.

**Figure 6. Typical Operating Circuit and Capacitor Values**

## PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
MAX213CDB	ACTIVE	SSOP	DB	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX213CDBR	ACTIVE	SSOP	DB	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX213CDW	ACTIVE	SOIC	DW	28	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX213CDWR	ACTIVE	SOIC	DW	28	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX213IDB	ACTIVE	SSOP	DB	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX213IDBR	ACTIVE	SSOP	DB	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX213IDW	ACTIVE	SOIC	DW	28	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
MAX213IDWR	ACTIVE	SOIC	DW	28	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

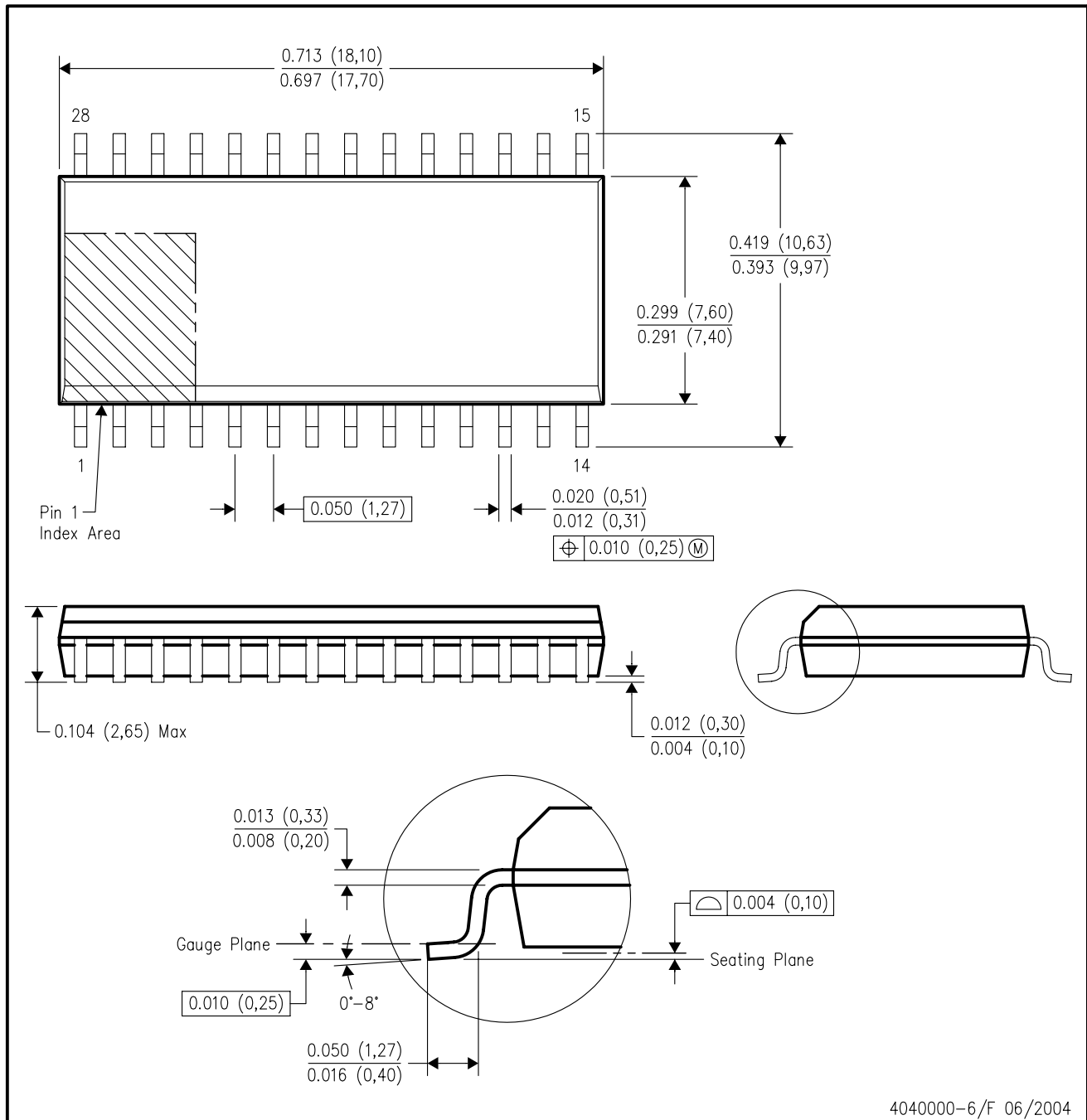
<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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DW (R-PDSO-G28)

PLASTIC SMALL-OUTLINE PACKAGE

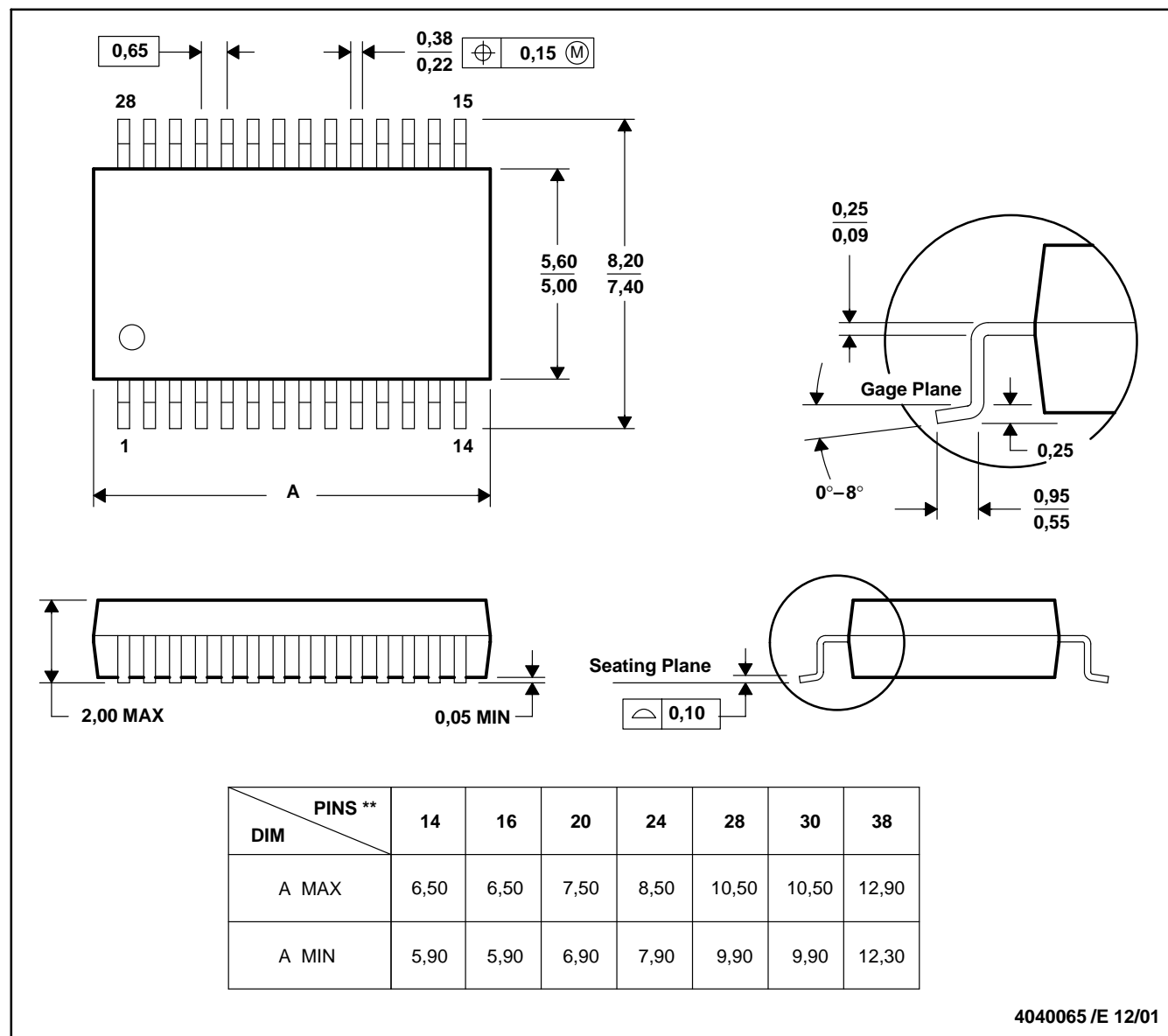


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## DB (R-PDSO-G\*\*)

## PLASTIC SMALL-OUTLINE

28 PINS SHOWN



- NOTES: A. All linear dimensions are in millimeters.  
 B. This drawing is subject to change without notice.  
 C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.  
 D. Falls within JEDEC MO-150

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DSP	<a href="http://dsp.ti.com">dsp.ti.com</a>	Broadband	<a href="http://www.ti.com/broadband">www.ti.com/broadband</a>
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Logic	<a href="http://logic.ti.com">logic.ti.com</a>	Military	<a href="http://www.ti.com/military">www.ti.com/military</a>
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Microcontrollers	<a href="http://microcontroller.ti.com">microcontroller.ti.com</a>	Security	<a href="http://www.ti.com/security">www.ti.com/security</a>
Low Power Wireless	<a href="http://www.ti.com/lpw">www.ti.com/lpw</a>	Telephony	<a href="http://www.ti.com/telephony">www.ti.com/telephony</a>
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